

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO. SERIAL NO.
027050-00001 10/804,228

LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

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KANAOKA, et al.						
FILING DATE	GROUP					
March 19, 2004	1746					

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	AA				<u> </u>		
	АВ			<u> </u>			
	AC						
	AD				<u> </u>		
	AE						
	AF						

FOREIGN PATENT DOCUMENTS

	,		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TR/ YES	ANSLAT NO F	ION PART.
4	A	AG	EP 1 354 907 A1	October 22, 2003	Europe			x		
		АН	EP 1 274 147 A2	January 8, 2003	Europe			х		
	T	Al	EP 1 138 712 A2	October 4, 2001	Europe			x		
	T_{-}	AJ	WO 94/24717	October 27, 1994	United States			х		
		AK	2002-313366	October 25, 2002	Japan					х
	l	AL	2002-367629	December 20, 2002	Japan					х
	ΩI	АМ	2002-358978	December 13, 2002	Japan			_		X
K	שו	AN	2002-373674	December 26, 2002	Japan					Х

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PH	AO	O. Savadogo, "Emerging Membranes for Electrochemical Systems: (I) Solid Polymer Electrolyte Membranes for Fuel Cell Systems," Journal of New Materials for Electrochemical Systems, Ecole Polytechnique De Montreal, Montreal, Canada, Vol. 1, 1998, pages 47-66.
	AP	

EXAMINER	DATE CONSIDERED /
1. Heltomes	3/05

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ATTORNEY DOCKET NUMBER

027050-00001

APPLICATION

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(Use several sheets if necessary)

Nagayuki KANAOKA et al.

FILING DATE GROUP ART UNIT

March 19, 2004

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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
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	AB	US 2002/0172850 A1	November 21, 2002	Yoichi ASANO et al.			January 22, 2002
	AC	US 2002/0177656 A1	November 28, 2002	Kohei GOTO et al.			March 26, 2002
AH	AD	US 2002/0188097 A1	December 12, 2002	Kohei GOTO et al.		<u> </u>	March 26, 2002
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FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB- CLASS	<u>TR/</u> YES	NSLAT	ION PART.
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	OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)	
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EXAMINER	1, Helston	DATE CONSIDERED 3/03
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